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Details

Product Status	Active
Core Processor	CPU16
Core Size	16-Bit
Speed	16MHz
Connectivity	EBI/EMI, SCI, SPI
Peripherals	POR, PWM, WDT
Number of I/O	16
Program Memory Size	-
Program Memory Type	ROMless
EEPROM Size	-
RAM Size	1K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 8x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mc68hc16z1mag16

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SECTION 1 INTRODUCTION

M68HC16 Z-series microcontrollers (including the MC68HC16Z1, MC68CM16Z1, MC68CK16Z1, MC68HC16Z2, MC68HC16Z3, MC68HC16Z4, and MC68CK16Z4) are high-speed 16-bit control units that are upwardly code compatible with M68HC11 controllers. All are members of the M68HC16 Family of modular microcontrollers.

M68HC16 microcontroller units (MCUs) are built from standard modules that interface via a common internal bus. Standardization facilitates rapid development of devices tailored for specific applications.

M68HC16 Z-series MCUs incorporate a number of different modules. Refer to [Table 1-1](#) for information on the contents of a specific Z-series MCU. (x) indicates that the module is used in the MCU. All of these modules are interconnected by the intermodule bus (IMB).

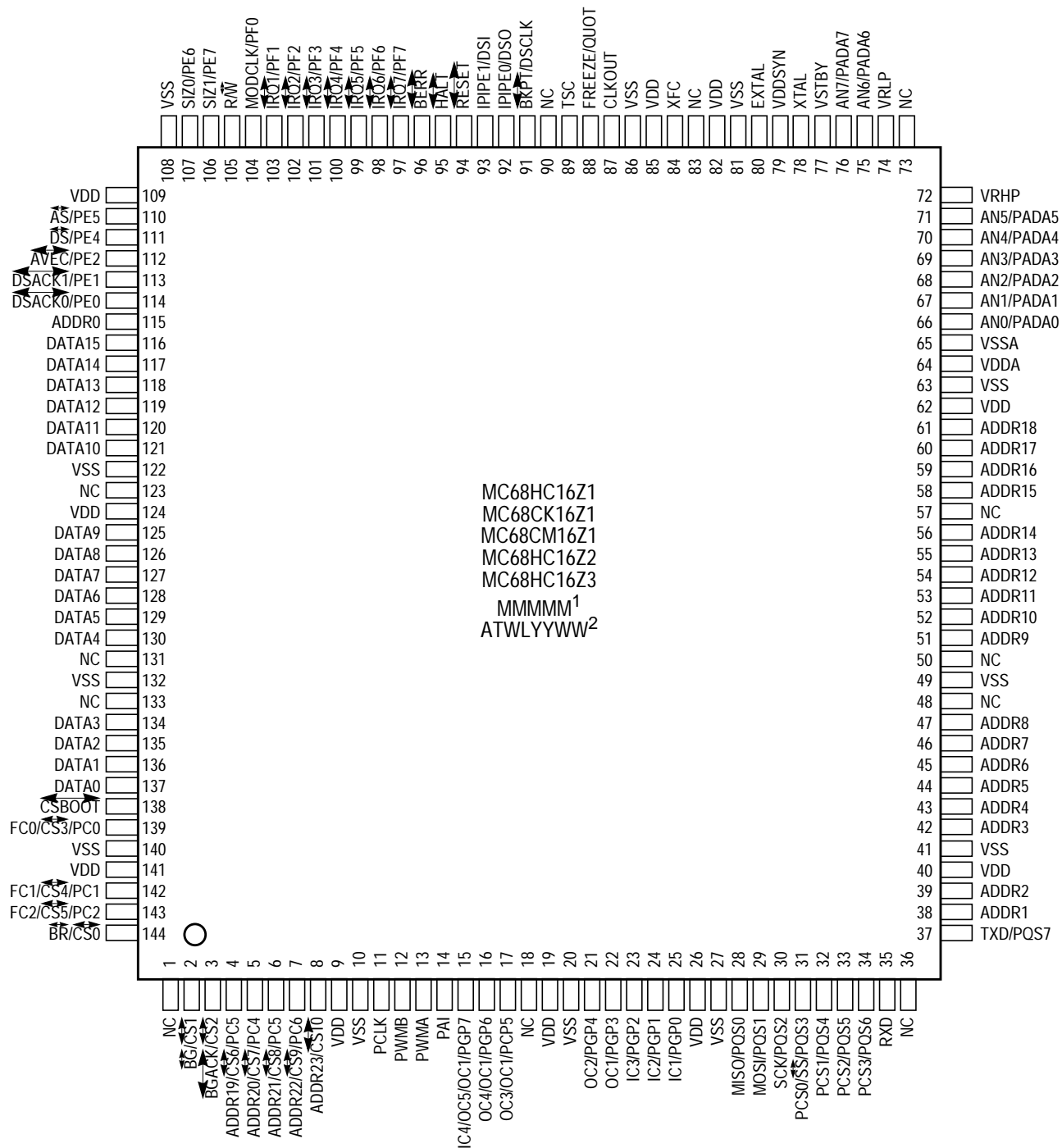
Table 1-1 M68HC16 Z-Series MCUs

Modules	MC68HC16Z1 MC68CK16Z1 ¹ MC68CM16Z1 ¹	MC68HC16Z2	MC68HC16Z3	MC68HC16Z4 MC68CK16Z4 ¹
Central Processor Unit (CPU16)	X	X	X	—
Low-Power Central Processor Unit (CPU16L)	—	—	—	X
System Integration Module (SIM)	X	X	X	—
Low-Power System Integration Module (SIML)	—	—	—	X
Standby RAM (SRAM)	1 Kbyte	2 Kbytes	4 Kbytes	1 Kbyte
Masked ROM Module (MRM)	—	8 Kbytes	8 Kbytes	—
Analog-to-Digital Converter (ADC)	X	X	X	X
Queued Serial Module (QSM)	X	X	X	—
Multichannel Communication Interface (MCCI)	—	—	—	X
General-Purpose Timer (GPT)	X	X	X	X

NOTES:

1. "C" designator indicates a 2.7V to 3.6V part; "M" indicates a fast reference frequency and "K" indicates a slow reference frequency. "HC" stands for HCMOS.

The maximum system clock for M68HC16 Z-series MCUs can be either 16.78 MHz, 20.97 MHz, or 25.17 MHz. An internal phase-locked loop circuit synthesizes the system clock from a slow (typically 32.768 kHz) or fast (typically 4.194 MHz) reference, or uses an external frequency source. Refer to [Table 1-2](#) for information on which reference frequency is applied to a particular MCU. (x) indicates the reference frequency applicable to the MCU.

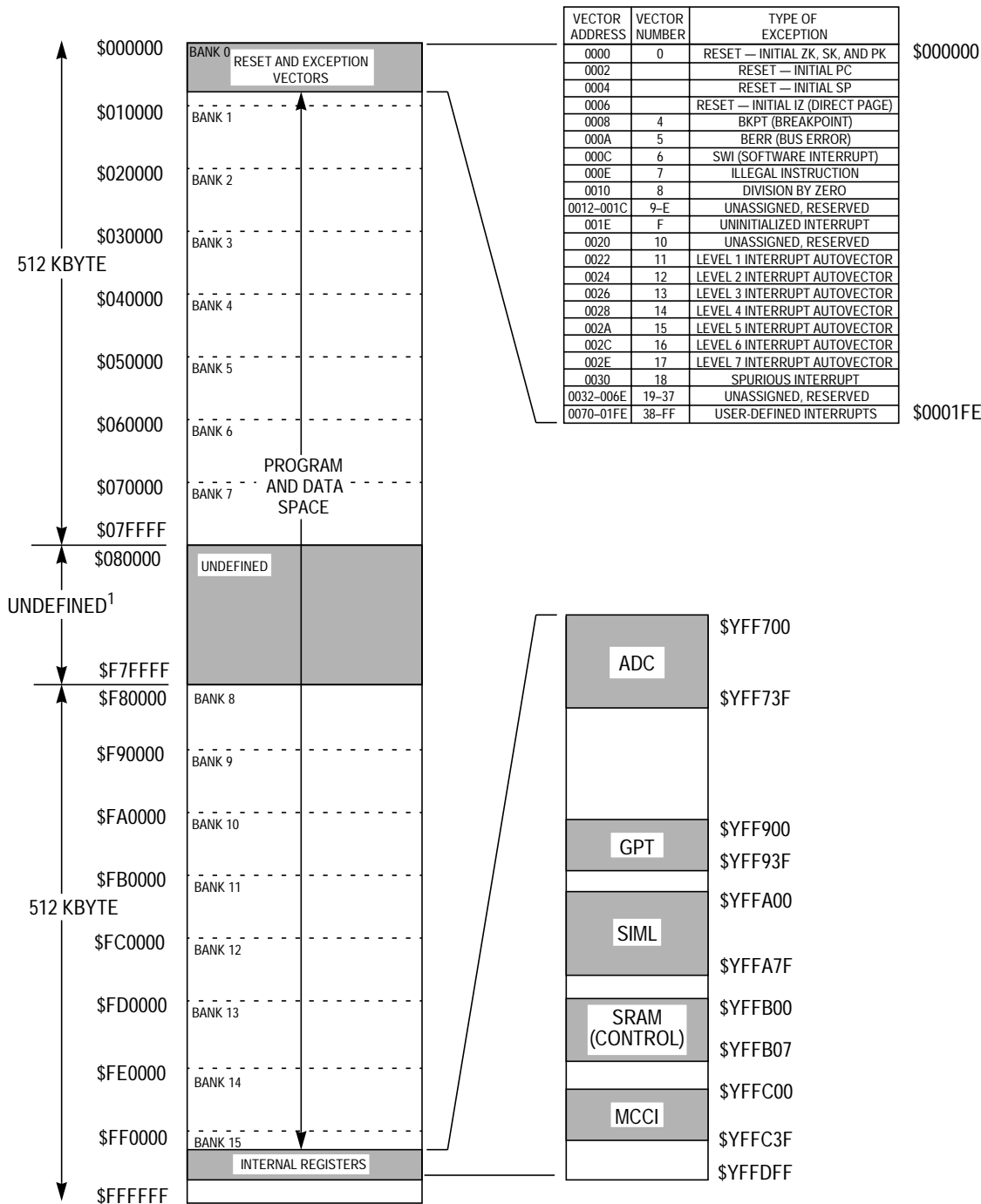


NOTES:

- 1. MMMMMM = MASK OPTION NUMBER
- 2. ATWLYYWW = ASSEMBLY TEST LOCATION/YEAR, WEEK

HC16Z1/CKZ1/CMZ1/Z2/Z3 144-PIN QFP

Figure 3-5 MC68HC16Z1/CKZ1/CMZ1/Z2/Z3 Pin Assignments for 144-Pin Package



NOTE:

1. THE ADDRESSES DISPLAYED IN THIS MEMORY MAP ARE THE FULL 24-BIT IMB ADDRESSES. THE CPU16 ADDRESS BUS IS 20 BITS WIDE, AND CPU16 ADDRESS LINE 19 DRIVES IMB ADDRESS LINES [23:20]. THE BLOCK OF ADDRESSES FROM \$080000 TO \$F7FFFF MARKED AS UNDEFINED WILL NEVER APPEAR ON THE IMB. MEMORY BANKS 0 TO 15 APPEAR FULLY CONTIGUOUS IN THE CPU16'S FLAT 20-BIT ADDRESS SPACE. THE CPU16 NEED ONLY GENERATE A 20-BIT EFFECTIVE ADDRESS TO ACCESS ANY LOCATION IN THIS RANGE.

HC16Z4/CKZ4 MEM MAP (C)

Figure 3-13 MC68HC16Z4/CKZ4 Combined Program and Data Space Map

Table 4-2 Instruction Set Summary

Mnemonic	Operation	Description	Address	Instruction			Condition Codes							
				Mode	Opcode	Operand	Cycles	S	MV	H	EV	N	Z	V
ABA	Add B to A	$(A) + (B) \Rightarrow A$	INH	370B	—	2	—	—	Δ	—	Δ	Δ	Δ	Δ
ABX	Add B to IX	$(XK : IX) + (000 : B) \Rightarrow XK : IX$	INH	374F	—	2	—	—	—	—	—	—	—	—
ABY	Add B to IY	$(YK : IY) + (000 : B) \Rightarrow YK : IY$	INH	375F	—	2	—	—	—	—	—	—	—	—
ABZ	Add B to IZ	$(ZK : IZ) + (000 : B) \Rightarrow ZK : IZ$	INH	376F	—	2	—	—	—	—	—	—	—	—
ACE	Add E to AM	$(AM[31:16]) + (E) \Rightarrow AM$	INH	3722	—	2	—	Δ	—	Δ	—	—	—	—
ACED	Add E : D to AM	$(AM) + (E : D) \Rightarrow AM$	INH	3723	—	4	—	Δ	—	Δ	—	—	—	—
ADCA	Add with Carry to A	$(A) + (M) + C \Rightarrow A$	IND8, X	43	ff	6	—	—	Δ	—	Δ	Δ	Δ	Δ
			IND8, Y	53	ff	6								
			IND8, Z	63	ff	6								
			IMM8	73	ii	2								
			IND16, X	1743	gggg	6								
			IND16, Y	1753	gggg	6								
			IND16, Z	1763	gggg	6								
			EXT	1773	hh ll	6								
			E, X	2743	—	6								
			E, Y	2753	—	6								
			E, Z	2763	—	6								
ADCB	Add with Carry to B	$(B) + (M) + C \Rightarrow B$	IND8, X	C3	ff	6	—	—	Δ	—	Δ	Δ	Δ	Δ
			IND8, Y	D3	ff	6								
			IND8, Z	E3	ff	6								
			IMM8	F3	ii	2								
			IND16, X	17C3	gggg	6								
			IND16, Y	17D3	gggg	6								
			IND16, Z	17E3	gggg	6								
			EXT	17F3	hh ll	6								
			E, X	27C3	—	6								
			E, Y	27D3	—	6								
			E, Z	27E3	—	6								
ADCD	Add with Carry to D	$(D) + (M : M + 1) + C \Rightarrow D$	IND8, X	83	ff	6	—	—	—	—	Δ	Δ	Δ	Δ
			IND8, Y	93	ff	6								
			IND8, Z	A3	ff	6								
			IMM16	37B3	jj kk	4								
			IND16, X	37C3	gggg	6								
			IND16, Y	37D3	gggg	6								
			IND16, Z	37E3	gggg	6								
			EXT	37F3	hh ll	6								
			E, X	2783	—	6								
			E, Y	2793	—	6								
			E, Z	27A3	—	6								
ADCE	Add with Carry to E	$(E) + (M : M + 1) + C \Rightarrow E$	IMM16	3733	jj kk	4	—	—	—	—	Δ	Δ	Δ	Δ
			IND16, X	3743	gggg	6								
			IND16, Y	3753	gggg	6								
			IND16, Z	3763	gggg	6								
			EXT	3773	hh ll	6								
ADDA	Add to A	$(A) + (M) \Rightarrow A$	IND8, X	41	ff	6	—	—	Δ	—	Δ	Δ	Δ	Δ
			IND8, Y	51	ff	6								
			IND8, Z	61	ff	6								
			IMM8	71	ii	2								
			IND16, X	1741	gggg	6								
			IND16, Y	1751	gggg	6								
			IND16, Z	1761	gggg	6								
			EXT	1771	hh ll	6								
			E, X	2741	—	6								
			E, Y	2751	—	6								
			E, Z	2761	—	6								

Table 4-2 Instruction Set Summary (Continued)

Mnemonic	Operation	Description	Address	Instruction			Condition Codes								
			Mode	Opcode	Operand	Cycles	S	MV	H	EV	N	Z	V	C	
RORW	Rotate Right Word		IND16, X	270E	gggg	8	—	—	—	—	Δ	Δ	Δ	Δ	
			IND16, Y	271E	gggg	8									
			IND16, Z	272E	gggg	8									
			EXT	273E	hh ll	8									
RTI ³	Return from Interrupt	(SK : SP) + 2 ⇒ SK : SP Pull CCR (SK : SP) + 2 ⇒ SK : SP Pull PC (PK : PC) - 6 ⇒ PK : PC	INH	2777	—	12	Δ	Δ	Δ	Δ	Δ	Δ	Δ		
RTS ⁴	Return from Subroutine	(SK : SP) + 2 ⇒ SK : SP Pull PK (SK : SP) + 2 ⇒ SK : SP Pull PC (PK : PC) - 2 ⇒ PK : PC	INH	27F7	—	12	—	—	—	—	—	—	—		
SBA	Subtract B from A	(A) - (B) ⇒ A	INH	370A	—	2	—	—	—	—	Δ	Δ	Δ	Δ	
SBCA	Subtract with Carry from A	(A) - (M) - C ⇒ A	IND8, X	42	ff	6	—	—	—	—	Δ	Δ	Δ	Δ	
			IND8, Y	52	ff	6									
			IND8, Z	62	ff	6									
			IMM8	72	ii	2									
			IND16, X	1742	gggg	6									
			IND16, Y	1752	gggg	6									
			IND16, Z	1762	gggg	6									
			EXT	1772	hh ll	6									
			E, X	2742	—	6									
			E, Y	2752	—	6									
E, Z	2762	—	6												
SBCB	Subtract with Carry from B	(B) - (M) - C ⇒ B	IND8, X	C2	ff	6	—	—	—	—	Δ	Δ	Δ	Δ	
			IND8, Y	D2	ff	6									
			IND8, Z	E2	ff	6									
			IMM8	F2	ii	2									
			IND16, X	17C2	gggg	6									
			IND16, Y	17D2	gggg	6									
			IND16, Z	17E2	gggg	6									
			EXT	17F2	hh ll	6									
			E, X	27C2	—	6									
			E, Y	27D2	—	6									
E, Z	27E2	—	6												
SBCD	Subtract with Carry from D	(D) - (M : M + 1) - C ⇒ D	IND8, X	82	ff	6	—	—	—	—	Δ	Δ	Δ	Δ	
			IND8, Y	92	ff	6									
			IND8, Z	A2	ff	6									
			IMM16	37B2	jj kk	4									
			IND16, X	37C2	gggg	6									
			IND16, Y	37D2	gggg	6									
			IND16, Z	37E2	gggg	6									
			EXT	37F2	hh ll	6									
			E, X	2782	—	6									
			E, Y	2792	—	6									
E, Z	27A2	—	6												
SBCE	Subtract with Carry from E	(E) - (M : M + 1) - C ⇒ E	IMM16	3732	jj kk	4	—	—	—	—	Δ	Δ	Δ	Δ	
			IND16, X	3742	gggg	6									
			IND16, Y	3752	gggg	6									
			IND16, Z	3762	gggg	6									
EXT	3772	hh ll	6												
SDE	Subtract D from E	(E) - (D) ⇒ E	INH	2779	—	2	—	—	—	—	Δ	Δ	Δ	Δ	
STAA	Store A	(A) ⇒ M	IND8, X	4A	ff	4	—	—	—	—	Δ	Δ	0	—	
			IND8, Y	5A	ff	4									
			IND8, Z	6A	ff	4									
			IND16, X	174A	gggg	6									
			IND16, Y	175A	gggg	6									
			IND16, Z	176A	gggg	6									
			EXT	177A	hh ll	6									
			E, X	274A	—	4									
			E, Y	275A	—	4									
E, Z	276A	—	4												

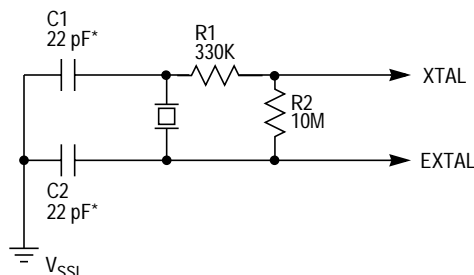
5.3.1 Clock Sources

The state of the clock mode (MODCLK) pin during reset determines the system clock source. When MODCLK is held high during reset, the clock synthesizer generates a clock signal from an external reference frequency. The clock synthesizer control register (SYNCR) determines operating frequency and mode of operation. When MODCLK is held low during reset, the clock synthesizer is disabled and an external system clock signal must be driven onto the EXTAL pin.

The input clock, referred to as f_{ref} , can be either a crystal or an external clock source. The output of the clock system is referred to as f_{sys} . Ensure that f_{ref} and f_{sys} are within normal operating limits.

To generate a reference frequency using the crystal oscillator, a reference crystal must be connected between the EXTAL and XTAL pins. Typically, a 32.768-kHz crystal is used for a slow reference, but the frequency may vary between 25 kHz to 50 kHz.

Figure 5-3 shows a typical circuit.

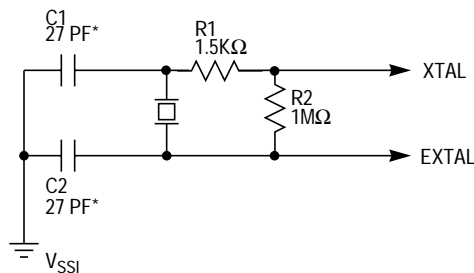


* RESISTANCE AND CAPACITANCE BASED ON A TEST CIRCUIT CONSTRUCTED WITH A DAISHINKU DMX-38 32.768-kHz CRYSTAL. SPECIFIC COMPONENTS MUST BE BASED ON CRYSTAL TYPE. CONTACT CRYSTAL VENDOR FOR EXACT CIRCUIT.

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Figure 5-3 Slow Reference Crystal Circuit

A 4.194-MHz crystal is typically used for a fast reference, but the frequency may vary between one MHz up to six MHz. **Figure 5-4** shows a typical circuit.



* RESISTANCE AND CAPACITANCE BASED ON A TEST CIRCUIT CONSTRUCTED WITH A KDS041-18 4.194 MHz CRYSTAL. SPECIFIC COMPONENTS MUST BE BASED ON CRYSTAL TYPE. CONTACT CRYSTAL VENDOR FOR EXACT CIRCUIT.

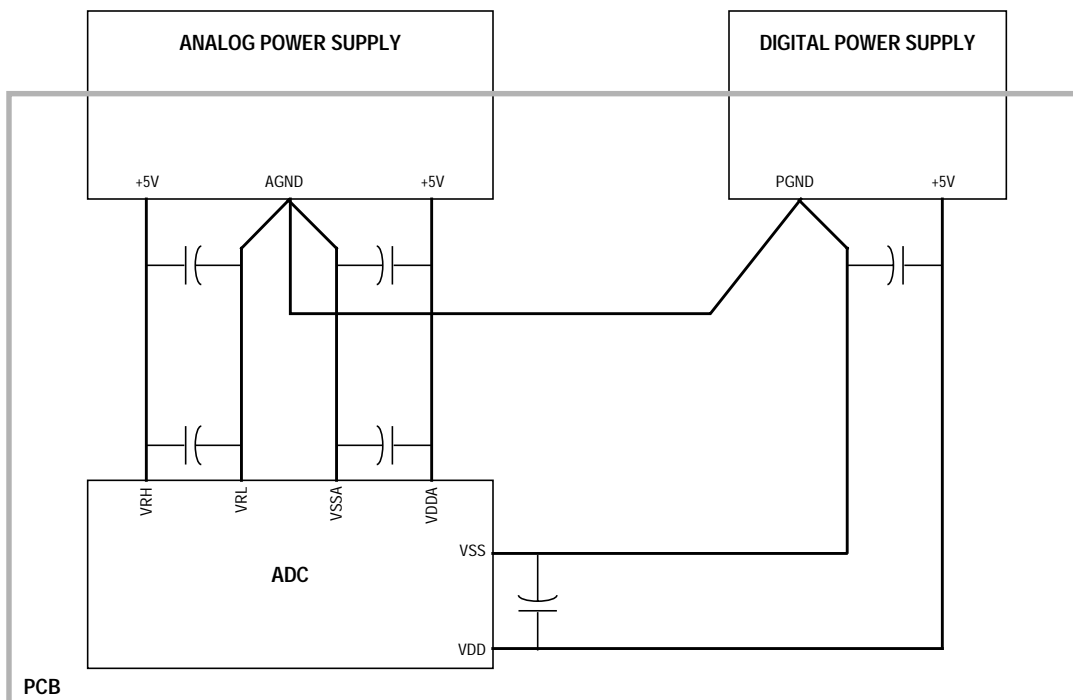
16 OSCILLATOR 4M

Figure 5-4 Fast Reference Crystal Circuit

Grounding is the most important factor influencing analog circuit performance in mixed signal systems (or in stand-alone analog systems). Close attention must be paid to avoid introducing additional sources of noise into the analog circuitry. Common sources of noise include ground loops, inductive coupling, and combining digital and analog grounds together inappropriately.

The problem of how and when to combine digital and analog grounds arises from the large transients which the digital ground must handle. If the digital ground is not able to handle the large transients, the current from the large transients can return to ground through the analog ground. It is the excess current overflowing into the analog ground which causes performance degradation by developing a differential voltage between the true analog ground and the microcontroller's ground pin. The end result is that the ground observed by the analog circuit is no longer true ground and often ends in skewed results.

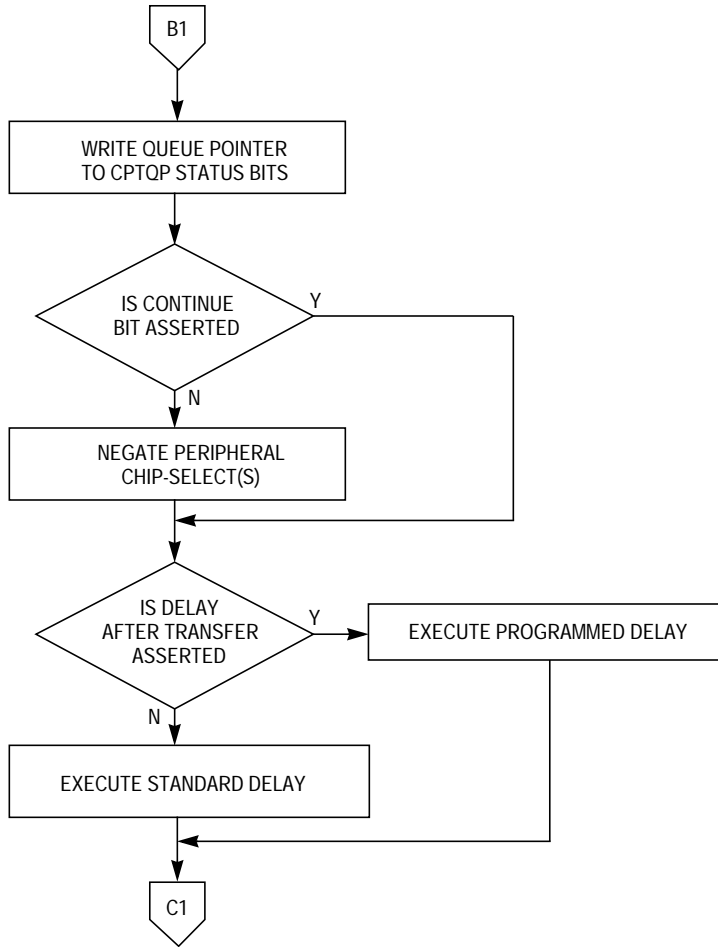
Two similar approaches designed to improve or eliminate the problems associated with grounding excess transient currents involve star-point ground systems. One approach is to star-point the different grounds at the power supply origin, thus keeping the ground isolated. Refer to [Figure 8-6](#).



ADC POWER SCHEM

Figure 8-6 Star-Ground at the Point of Power Supply Origin

Another approach is to star-point the different grounds near the analog ground pin on the microcontroller by using small traces for connecting the non-analog grounds to the analog ground. The small traces are meant only to accommodate DC differences, not AC transients.



QSPI MSTR2 FLOW 3

Figure 9-6 Flowchart of QSPI Master Operation (Part 2)

A receiver is placed in wake-up mode by setting the RWU bit in SCCR1. While RWU is set, receiver status flags and interrupts are disabled. Although the CPU16 can clear RWU, it is normally cleared by hardware during wake-up.

The WAKE bit in SCCR1 determines which type of wake-up is used. When WAKE = 0, idle-line wake-up is selected. When WAKE = 1, address-mark wake-up is selected. Both types require a software-based device addressing and recognition scheme.

Idle-line wake-up allows a receiver to sleep until an idle line is detected. When an idle-line is detected, the receiver clears RWU and wakes up. The receiver waits for the first frame of the next transmission. The byte is received normally, transferred to RDR, and the RDRF flag is set. If software does not recognize the address, it can set RWU and put the receiver back to sleep. For idle-line wake-up to work, there must be a minimum of one frame of idle line between transmissions. There must be no idle time between frames within a transmission.

Address-mark wake-up uses a special frame format to wake up the receiver. When the MSB of an address-mark frame is set, that frame contains address information. The first frame of each transmission must be an address frame. When the MSB of a frame is set, the receiver clears RWU and wakes up. The byte is received normally, transferred to the RDR, and the RDRF flag is set. If software does not recognize the address, it can set RWU and put the receiver back to sleep. Address-mark wake-up allows idle time between frames and eliminates idle time between transmissions. However, there is a loss of efficiency because of an additional bit-time per frame.

9.4.3.9 Internal Loop Mode

The LOOPS bit in SCCR1 controls a feedback path in the data serial shifter. When LOOPS is set, the SCI transmitter output is fed back into the receive serial shifter. TXD is asserted (idle line). Both transmitter and receiver must be enabled before entering loop mode.

10.3.4.2 CPHA = 1 Transfer Format

Figure 10-4 is a timing diagram of an 8-bit, MSB-first SPI transfer in which CPHA equals one. Two waveforms are shown for SCK, one for CPOL equal to zero and another for CPOL equal to one. The diagram may be interpreted as a master or slave timing diagram since the SCK, MISO and MOSI pins are directly connected between the master and the slave. The MISO signal shown is the output from the slave and the MOSI signal shown is the output from the master. The \overline{SS} line is the slave select input to the slave.

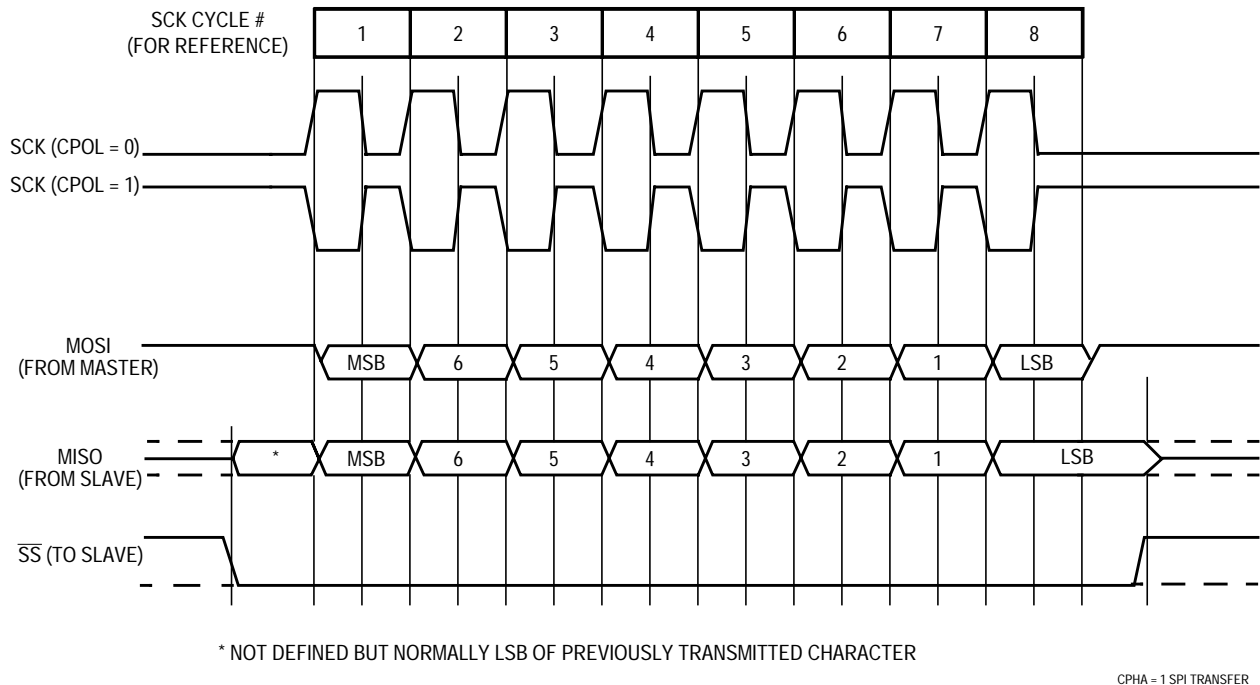


Figure 10-4 CPHA = 1 SPI Transfer Format

For a master, writing to the SPDR initiates the transfer. For a slave, the first edge of SCK indicates the start of a transfer. The SPI is left-shifted on the first and each succeeding odd clock edge, and data is latched on the second and succeeding even clock edges.

SCK is inactive for the last half of the eighth SCK cycle. For a master, SPIF is set at the end of the eighth SCK cycle (after the seventeenth SCK edge). Since the last SCK edge occurs in the middle of the eighth SCK cycle, however, the slave has no way of knowing when the end of the last SCK cycle occurs. The slave therefore considers the transfer complete after the last bit of serial data has been sampled, which corresponds to the middle of the eighth SCK cycle.

When CPHA is one, the \overline{SS} line may remain at its active low level between transfers. This format is sometimes preferred in systems having a single fixed master and only one slave that needs to drive the MISO data line.

Table A-11 Low Voltage 16.78-MHz DC Characteristics (Continued)
 $(V_{DD} \text{ and } V_{DDSYN} = 2.7 \text{ to } 3.6\text{Vdc}, V_{SS} = 0 \text{ Vdc}, T_A = T_L \text{ to } T_H)$

Num	Characteristic	Symbol	Min	Max	Unit
17	MC68CM16Z1/Z4 Power Dissipation ¹¹	P_D	—	191	mW
18	Input Capacitance ^{2, 7}	C_{in}	—	10	pF
	All input-only pins				
19	All input/output pins	C_L	—	100	pF
	Load Capacitance ²				
	Group 1 I/O Pins, CLKOUT, FREEZE/QUOT, IPIPE0				
	Group 2 I/O Pins and CSBOOT, BG/CS				
	Group 3 I/O Pins				
Group 4 I/O Pins					

NOTES:
1. Applies to:

- Port ADA [7:0] — AN[7:0]
- Port E [7:4] — SIZ[1:0], AS, DS
- Port F [7:0] — IRQ[7:1], MODCLK
- Port GP[7:0] — IC4/OC5/OC1, IC[3:1], OC[4:1]/OC1
- Port MCCI[7:0] — TXD, PCS[3:1], PCS0/SS, SCK, MOSI, MISO
- BKPT/DSCLK, DSI/IPIPE1, PAI, PCLK, RESET, RXD, TSC

2. Input-Only Pins: EXTAL, TSC, BKPT/DSCLK, PAI, PCLK, RXD
Output-Only Pins: CSBOOT, BG/CS, CLKOUT, FREEZE/QUOT, DSO/IPIPE0, PWMA, PWMB
Input/Output Pins:

Group 1: Port GP[7:0] — IC4/OC5/OC1, IC[3:1], OC[4:1]/OC1, DATA[15:0], DSI/IPIPE1

Group 2: Port C[6:0] — ADDR[22:19]/CS[9:6], FC[2:0]/CS[5:3]

Port E[7:0] — SIZ[1:0], AS, DS, AVEC, DSACK[1:0]

Port F[7:0] — IRQ[7:1], MODCLK

Port MCCI[7:3] — TXD, PCS[3:1], PCS0/SS, ADDR23/CS10/ECLK

Group 3: HALT, RESET

Group 4: MISO, MOSI, SCK

3. Does not apply to HALT and RESET because they are open drain pins.

Does not apply to port MCCI[7:0] (TXD, PCS[3:1], PCS0/SS, SCK, MOSI, MISO) in wired-OR mode.

4. Use of an active pull-down device is recommended.
5. Total operating current is the sum of the appropriate I_{DD} , I_{DDSYN} , I_{SB} , and I_{DDA} .
6. Current measured with system clock frequency of 16.78 MHz, all modules active.
7. This parameter is periodically sampled rather than 100% tested.
8. CPU16 in WAIT, all other modules inactive.
9. The RAM module will not switch into standby mode as long as V_{SB} does not exceed V_{DD} by more than 0.5 Volt.

The RAM array cannot be accessed while the module is in standby mode.

10. When V_{DD} is transitioning during a power up or power down sequence, and V_{SB} is applied, current flows between the V_{STBY} and V_{DD} pins, which causes standby current to increase toward the maximum transient condition specification. System noise on the V_{DD} and V_{STBY} pins can contribute to this condition.
11. Power dissipation measured at specified system clock frequency, all modules active. Power dissipation can be calculated using the expression:

$$P_D = \text{Maximum } V_{DD} (I_{DD} + I_{DDSYN} + I_{SB}) + \text{Maximum } V_{DDA} (I_{DDA})$$

 I_{DD} includes supply currents for all device modules powered by V_{DD} pins.

Table A-21 20.97-MHz Background Debug Mode Timing
 $(V_{DD} \text{ and } V_{DDSYN} = 5.0 \text{ Vdc} \pm 5\%, V_{SS} = 0 \text{ Vdc}, T_A = T_L \text{ to } T_H)^1$

Num	Characteristic	Symbol	Min	Max	Unit
B0	DSI Input Setup Time	t_{DSISU}	15	—	ns
B1	DSI Input Hold Time	t_{DSIH}	10	—	ns
B2	DSCLK Setup Time	t_{DSCSU}	15	—	ns
B3	DSCLK Hold Time	t_{DSCH}	10	—	ns
B4	DSO Delay Time	t_{DSOD}	—	25	ns
B5	DSCLK Cycle Time	t_{DSCCYC}	2	—	t_{cyc}
B6	CLKOUT High to FREEZE Asserted/Negated	t_{FRZAN}	—	50	ns
B7	CLKOUT High to IPIPE1 High Impedance	t_{IFZ}	—	50	ns
B8	CLKOUT High to IPIPE1 Valid	t_{IF}	—	50	ns
B9	DSCLK Low Time	t_{DSCLO}	1	—	t_{cyc}
B10	IPIPE1 High Impedance to FREEZE Asserted	t_{IPFA}	TBD	—	t_{cyc}
B11	FREEZE Negated to IPIPE[0:1] Active	t_{FRIP}	TBD	—	t_{cyc}

NOTES:

- All AC timing is shown with respect to V_{IH}/V_{IL} levels unless otherwise noted.

Table A-22 25.17-MHz Background Debug Mode Timing
 $(V_{DD} \text{ and } V_{DDSYN} = 5.0 \text{ Vdc} \pm 5\%, V_{SS} = 0 \text{ Vdc}, T_A = T_L \text{ to } T_H)^1$

Num	Characteristic	Symbol	Min	Max	Unit
B0	DSI Input Setup Time	t_{DSISU}	10	—	ns
B1	DSI Input Hold Time	t_{DSIH}	5	—	ns
B2	DSCLK Setup Time	t_{DSCSU}	10	—	ns
B3	DSCLK Hold Time	t_{DSCH}	5	—	ns
B4	DSO Delay Time	t_{DSOD}	—	20	ns
B5	DSCLK Cycle Time	t_{DSCCYC}	2	—	t_{cyc}
B6	CLKOUT High to FREEZE Asserted/Negated	t_{FRZAN}	—	20	ns
B7	CLKOUT High to IPIPE1 High Impedance	t_{IFZ}	—	20	ns
B8	CLKOUT High to IPIPE1 Valid	t_{IF}	—	20	ns
B9	DSCLK Low Time	t_{DSCLO}	1	—	t_{cyc}
B10	IPIPE1 High Impedance to FREEZE Asserted	t_{IPFA}	TBD	—	t_{cyc}
B11	FREEZE Negated to IPIPE[0:1] Active	t_{FRIP}	TBD	—	t_{cyc}

NOTES:

- All AC timing is shown with respect to V_{IH}/V_{IL} levels unless otherwise noted.

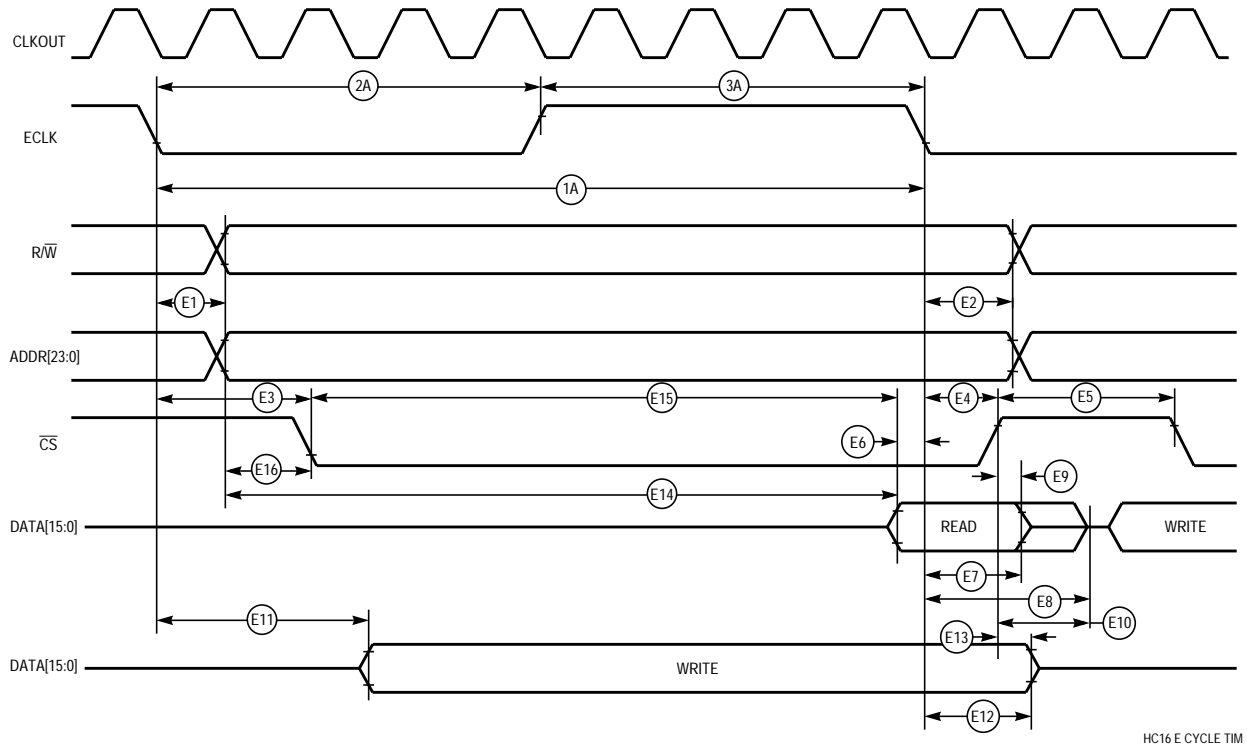


Figure A-15 ECLK Timing Diagram

Table A-27 Low Voltage QSPI Timing
 $(V_{DD} \text{ and } V_{DSSYN} = 2.7 \text{ to } 3.6 \text{ Vdc, } V_{SS} = 0 \text{ Vdc, } T_A = T_L \text{ to } T_H)^1$

Num	Function	Symbol	Min	Max	Unit
1	Operating Frequency Master Slave	f_{op}	DC DC	1/4 1/4	f_{sys} f_{sys}
2	Cycle Time Master Slave	t_{qcyt}	4 4	510 —	t_{cyc} t_{cyc}
3	Enable Lead Time Master Slave	t_{lead}	2 2	128 —	t_{cyc} t_{cyc}
4	Enable Lag Time Master Slave	t_{lag}	— 2	1/2 —	SCK t_{cyc}
5	Clock (SCK) High or Low Time Master Slave ²	t_{sw}	$2 t_{cyc} - 60$ $2 t_{cyc} - n$	$255 t_{cyc}$ —	ns ns
6	Sequential Transfer Delay Master Slave (Does Not Require Deselect)	t_{td}	17 13	8192 —	t_{cyc} t_{cyc}
7	Data Setup Time (Inputs) Master Slave	t_{su}	20 20	— —	ns ns
8	Data Hold Time (Inputs) Master Slave	t_{hi}	30 20	— —	ns ns
9	Slave Access Time	t_a	—	1	t_{cyc}
10	Slave MISO Disable Time	t_{dis}	—	2	t_{cyc}
11	Data Valid (after SCK Edge) Master Slave	t_v	— —	50 50	ns ns
12	Data Hold Time (Outputs) Master Slave	t_{ho}	0 0	— —	ns ns
13	Rise Time Input Output	t_{ri} t_{ro}	— —	2 30	μs ns
14	Fall Time Input Output	t_{fi} t_{fo}	— —	2 30	μs ns

NOTES:

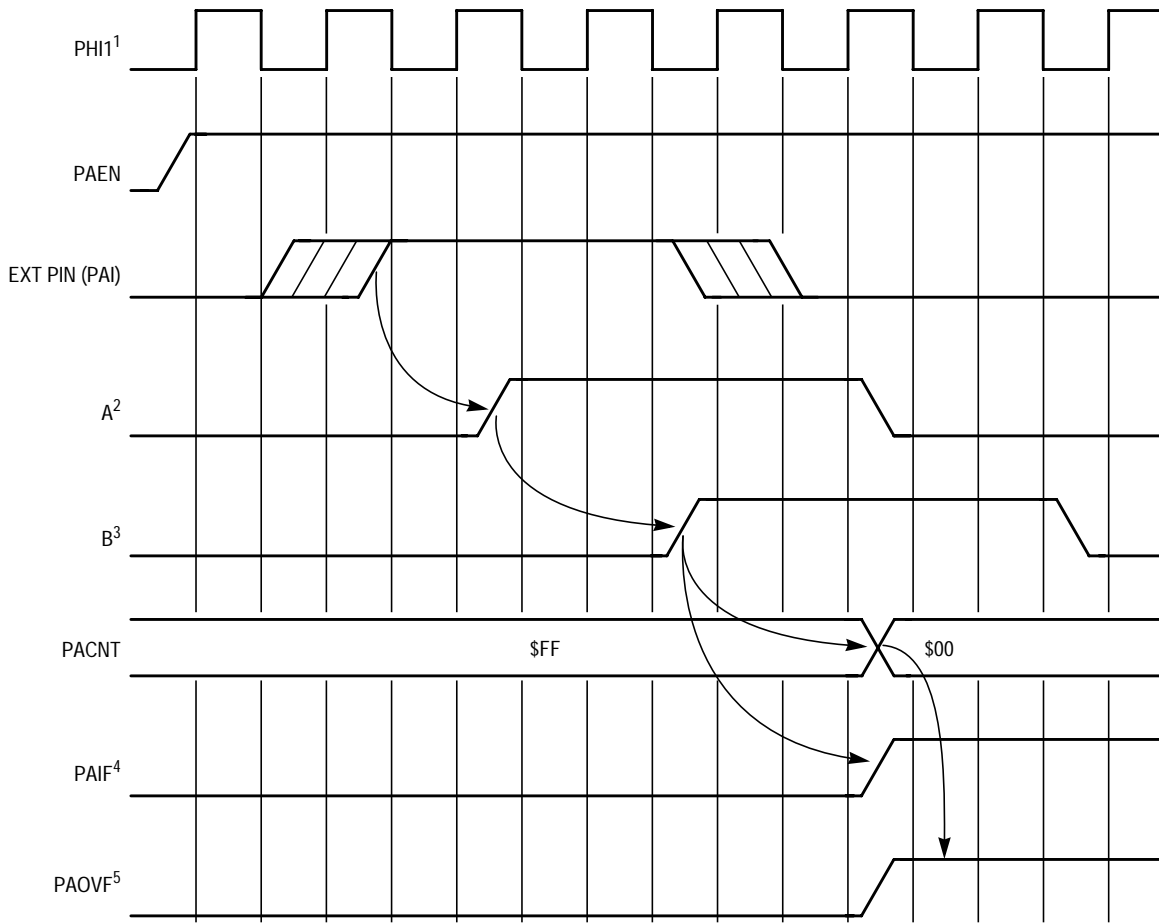
1. Refer to notes in [Table A-28](#).

Table A-28 QSPI Timing
 $(V_{DD} \text{ and } V_{DDSYN} = 5.0 \text{ Vdc} \pm 5\% \text{ for } 16.78 \text{ MHz, } 10\% \text{ for } 20/25 \text{ MHz, } V_{SS} = 0 \text{ Vdc, } T_A = T_L \text{ to } T_H)^1$

Num	Function	Symbol	Min	Max	Unit
1	Operating Frequency	f_{op}	DC	1/4	f_{sys}
	Master Slave		DC	1/4	f_{sys}
2	Cycle Time	t_{qcyt}	4	510	t_{cyc}
	Master Slave		4	—	t_{cyc}
3	Enable Lead Time	t_{lead}	2	128	t_{cyc}
	Master Slave		2	—	t_{cyc}
4	Enable Lag Time	t_{lag}	—	1/2	SCK
	Master Slave		2	—	t_{cyc}
5	Clock (SCK) High or Low Time	t_{sw}	$2 t_{cyc} - 60$	$255 t_{cyc}$	ns
	Master Slave ²		$2 t_{cyc} - n$	—	ns
6	Sequential Transfer Delay	t_{td}	17	8192	t_{cyc}
	Master Slave (Does Not Require Deselect)		13	—	t_{cyc}
7	Data Setup Time (Inputs)	t_{su}	30	—	ns
	Master Slave		20	—	ns
8	Data Hold Time (Inputs)	t_{hi}	0	—	ns
	Master Slave		20	—	ns
9	Slave Access Time	t_a	—	1	t_{cyc}
10	Slave MISO Disable Time	t_{dis}	—	2	t_{cyc}
11	Data Valid (after SCK Edge)	t_v	—	50	ns
	Master Slave		—	50	ns
12	Data Hold Time (Outputs)	t_{ho}	0	—	ns
	Master Slave		0	—	ns
13	Rise Time	t_{ri} t_{ro}	—	2	μs
	Input Output		—	30	ns
14	Fall Time	t_{fi} t_{fo}	—	2	μs
	Input Output		—	30	ns

NOTES:

1. All AC timing is shown with respect to V_{IH}/V_{IL} levels unless otherwise noted.
2. For high time, n = External SCK rise time; for low time, n = External SCK fall time.



NOTES:

1. PHI1 IS THE SAME FREQUENCY AS THE SYSTEM CLOCK; HOWEVER, IT DOES NOT HAVE THE SAME TIMING.
2. A = PAI SIGNAL AFTER THE SYNCHRONIZER.
3. B = "A" AFTER THE DIGITAL FILTER.
4. THE EXTERNAL LEADING EDGE CAUSES THE PULSE ACCUMULATOR TO INCREMENT AND THE PAIF FLAG TO BE SET.
5. THE COUNTER TRANSITION FROM \$FF TO \$00 CAUSES THE PAOVF FLAG TO BE SET.

PULSE ACCUM ECM LEAD EDGE

Figure A-25 Pulse Accumulator — Event Counting Mode (Leading Edge)

Table A-36 ADC AC Characteristics (Operating)

(V_{DD} and $V_{DDA} = 5.0 \text{ Vdc} \pm 5\%$ for 20/25 MHz, $\pm 10\%$ for 16 MHz, $V_{SS} = 0 \text{ Vdc}$,
 T_A within operating temperature range)

Num	Parameter	Symbol	Min	Max	Unit
1	ADC Clock Frequency	f_{ADCLK}	0.5	2.1	MHz
2	8-Bit Conversion Time ¹ $f_{ADCLK} = 1.0 \text{ MHz}$ $f_{ADCLK} = 2.1 \text{ MHz}$	t_{CONV}	15.2 7.6	—	μs
3	10-Bit Conversion Time ¹ $f_{ADCLK} = 1.0 \text{ MHz}$ $f_{ADCLK} = 2.1 \text{ MHz}$	t_{CONV}	17.1 8.6	—	μs
4	Stop Recovery Time	t_{SR}	—	10	μs

NOTES:

1. Conversion accuracy varies with f_{ADCLK} rate. Reduced conversion accuracy occurs at maximum.

D.2.1 SIM Module Configuration Register

SIMCR — SIM Module Configuration Register

\$YFFA00

15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
EXOFF	FRZSW	FRZBM	0	RSVD ¹	0	SHEN[1:0]		SUPV	MM	0	0	IARB[3:0]			

RESET:

0	1	1	0	$\overline{\text{DATA11}}$	0	0	0	1	1	0	0	1	1	1	1
---	---	---	---	----------------------------	---	---	---	---	---	---	---	---	---	---	---

NOTES:

1. This bit must be left at zero. Pulling $\overline{\text{DATA11}}$ high during reset ensures this bit remains zero. A one in this bit could allow the MCU to enter an unsupported operating mode.

SIMCR controls system configuration. SIMCR can be read or written at any time, except for the module mapping (MM) bit, which can only be written once after reset, and the reserved bit, which is read-only. Write has no effect.

EXOFF — External Clock Off

- 0 = The CLKOUT pin is driven during normal operation.
- 1 = The CLKOUT pin is placed in a high-impedance state.

FRZSW — Freeze Software Enable

- 0 = When FREEZE is asserted, the software watchdog and periodic interrupt timer continue to operate, allowing interrupts during background debug mode.
- 1 = When FREEZE is asserted, the software watchdog and periodic interrupt timer are disabled, preventing interrupts during background debug mode.

FRZBM — Freeze Bus Monitor Enable

- 0 = When FREEZE is asserted, the bus monitor continues to operate.
- 1 = When FREEZE is asserted, the bus monitor is disabled.

SHEN[1:0] — Show Cycle Enable

The SHEN field determines how the external bus is driven during internal transfer operations. A show cycle allows internal transfers to be monitored externally.

Table D-3 indicates whether show cycle data is driven externally, and whether external bus arbitration can occur. To prevent bus conflict, external devices must not be selected during show cycles.

Table D-3 Show Cycle Enable Bits

SHEN[1:0]	Action
00	Show cycles disabled, external arbitration enabled
01	Show cycles enabled, external arbitration disabled
10	Show cycles enabled, external arbitration enabled
11	Show cycles enabled, external arbitration enabled; internal activity is halted by a bus grant

SUPV — Supervisor/User Data Space

This bit has no effect because the CPU16 always operates in the supervisor mode.



```

STD      SCCR1          ;enable SCI receiver and transmitter

LDAB    #$01
TBZK                    ;point ZK at bank 1 (the SRAM)
LDZ     #$0000         ;for indexing the variables CNT and DLY

CNT     EQU    $0000    ;loop counter
DLY     EQU    $0002    ;delay counter

*****  Main Program  *****

MAIN:   LDAB    #$7F          ;set clock speed to 16.777MHz
        STAB    SYNCR          ;w=0, x=1, y=111111
NOT_L:  BRCLR   SYNCR+1,#8,NOT_L ;wait until synthesizer lock bit is set
        LDD    #$01B5
        STD    SCCR0          ;set baud rate to 1200
        JSR    DELAY          ;delay for modulus counter of SCI to flush
        LDX    #STRING        ;load address of string into IX
        JSR    SEND_STRING     ;subroutine to send string to dummy terminal
        LDAB   #$05          ;set up loop counter
        STAB   CNT,Z
LOOP1:  LDX    #SEC_STR        ;load address of string into IX
        JSR    SEND_STRING     ;subroutine to send string to dummy terminal
        DEC    CNT,Z          ;decrement loop counter
        BNE    LOOP1          ;loop 5 times

        LDAB   #$4F          ;change clock frequency to 4.194MHz
        STAB   SYNCR          ;w=0, x=1, y=001111
LOOP2:  BRCLR   SYNCR+1,#8,LOOP2 ;wait until synthesizer lock bit is set
        LDD    #$006D
        STD    SCCR0          ;set BAUD rate back to 1200
        JSR    DELAY          ;delay for modulus counter of SCI to flush
        LDX    #STRING2       ;load address of string into IX
        JSR    SEND_STRING     ;subroutine to send string to dummy terminal
        LDAB   #$05          ;set up # of loops for loop counter to 5
        STAB   CNT,Z
LOOP3:  LDX    #SEC_STR        ;load address of string into IX
        JSR    SEND_STRING     ;subroutine to send string to dummy terminal
        DEC    CNT,Z          ;decrement loop counter
        BNE    LOOP3          ;loop 5 times

        LBRA   MAIN          ;branch back to main

*****  Subroutines  *****

DELAY:  LDD    #$FFFF          ;delay loop
        STD    DLY,Z
LOOP4:  DEC    DLY,Z
        BNE    LOOP4
        RTS

SEND_STRING: ;subroutine to send out the entire ASCII
           ;string
        LDAB   0,X            ;get next byte in string as pointed to by IX
        BEQ    STRING_DONE    ;if B=00, then message is done

```